# A5G35S004N

## Airfast RF Power GaN Transistor

Rev. 4 — November 2022

This RF power GaN transistor is designed for cellular base station applications covering the frequency range of 3300 to 4300 MHz.

#### 3500 MHz

Typical Single-Carrier W-CDMA Reference Circuit Performance:
 V<sub>DD</sub> = 48 Vdc, I<sub>DQ</sub> = 12 mA, P<sub>out</sub> = 24.5 dBm Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.<sup>(1)</sup>

Frequency	G <sub>ps</sub> (dB)	η <sub>D</sub> Output PAR (%) (dB)		ACPR (dBc)
3400 MHz	19.3	19.5	9.9	-38.7
3500 MHz	19.4	20.0	9.7	-40.3
3600 MHz	18.8	20.4	9.4	-42.1

1. All data measured in reference circuit with device soldered to printed circuit board.

#### 3700-4000 MHz

Typical Single-Carrier W-CDMA Reference Circuit Performance:
 V<sub>DD</sub> = 48 Vdc, I<sub>DQ</sub> = 10 mA, P<sub>out</sub> = 28 dBm Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.<sup>(1)</sup>

Frequency	G <sub>ps</sub> (dB)	η <sub>D</sub> (%)	Output PAR (dB)	ACPR (dBc)
3700 MHz	18.3	22.5	8.4	-35.2
3800 MHz	18.8	25.2	8.5	-38.6
3900 MHz	18.1	23.8	8.5	-41.2
4000 MHz	17.2	21.6	8.6	-42.4

1. All data measured in reference circuit with device soldered to printed circuit board.

#### 4100-4300 MHz

Typical Single-Carrier W-CDMA Reference Circuit Performance:
 V<sub>DD</sub> = 48 Vdc, I<sub>DQ</sub> = 10 mA, P<sub>out</sub> = 28 dBm Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.<sup>(1)</sup>

Frequency	G <sub>ps</sub> (dB)	η <sub>D</sub> Output PAR (%) (dB)		ACPR (dBc)
4100 MHz	17.6	26.5	7.6	-33.2
4200 MHz	17.2	26.5	7.8	-36.2
4300 MHz	16.5	26.5	7.9	-38.3

1. All data measured in reference circuit with device soldered to printed circuit board.

#### **Features**

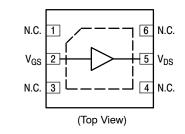
- · High terminal impedances for optimal broadband performance
- Designed for low complexity linearization systems
- · Universal broadband driver
- Optimized for massive MIMO active antenna systems for 5G base stations

## A5G35S004N

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3300–4300 MHz, 24.5 dBm Avg., 48 V AIRFAST RF POWER GaN TRANSISTOR





Note: Exposed backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections



### **Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	125	Vdc
Gate-Source Voltage	V <sub>GS</sub>	-16, 0	Vdc
Operating Voltage	$V_{DD}$	55	Vdc
Maximum Forward Gate Current @ T <sub>C</sub> = 25°C	I <sub>GMAX</sub>	0.74	mA
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Case Operating Temperature Range	T <sub>C</sub>	-55 to +150	°C
Maximum Channel Temperature	T <sub>CH</sub>	225	°C

### **Table 2. Recommended Operating Conditions**

Characteristic	Symbol	Value	Unit
Operating Voltage	$V_{DD}$	48	Vdc

#### **Table 3. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance by Infrared Measurement, Active Die Surface-to-Case Case Temperature 113°C, P <sub>D</sub> = 1.3 W	R <sub>0</sub> JC (IR)	8.9 (1)	°C/W
Thermal Resistance by Finite Element Analysis, Channel-to-Case Case Temperature 113°C, P <sub>D</sub> = 1.3 W	R <sub>θCHC</sub> (FEA)	32 (2)	°C/W

#### **Table 4. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JS-001-2017)	1A
Charge Device Model (per JS-002-2014)	C2A

## **Table 5. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

## Table 6. Electrical Characteristics (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics					
Off-State Drain Leakage (V <sub>DS</sub> = 150 Vdc, V <sub>GS</sub> = -8 Vdc)	I <sub>D(BR)</sub>	_	_	0.74	mAdc
On Characteristics					
Gate Threshold Voltage $(V_{DS} = 10 \text{ Vdc}, I_D = 0.74 \text{ mAdc})$	V <sub>GS(th)</sub>	-4.9	-2.5	-1.9	Vdc
Gate Quiescent Voltage (V <sub>DD</sub> = 48 Vdc, I <sub>D</sub> = 12 mAdc, Measured in Functional Test)	V <sub>GS(Q)</sub>	-2.78	-2.53	-2.30	Vdc
Gate-Source Leakage Current (V <sub>DS</sub> = 150 Vdc, V <sub>GS</sub> = -12 Vdc)	I <sub>GSS</sub>	-0.74	_	_	mAdc

<sup>1.</sup> Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to <a href="http://www.nxp.com/RF">http://www.nxp.com/RF</a> and search for AN1955.

(continued)

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<sup>2.</sup>  $R_{\theta CHC}$  (FEA) must be used for purposes related to reliability and limitations on maximum channel temperature. MTTF may be estimated by the expression MTTF (hours) =  $10^{[A+B/(T+273)]}$ , where T is the channel temperature in degrees Celsius, A = -11.1 and B = 8366.

Table 6. Electrical Characteristics (T<sub>A</sub> = 25°C unless otherwise noted) (continued)

Characteristic	Symbol	Min	Тур	Max	Unit
<b>Functional Tests</b> $^{(1)}$ (In NXP Production Test Fixture, 50 ohm system) $V_{DD} = 4$ 1-tone CW.	48 Vdc, I <sub>DQ</sub> =	12 mA, P <sub>out</sub> =	= 24.5 dBm Av	g., f = 3500 MI	Hz,

Power Gain	G <sub>ps</sub>	15.5	16.9	19.5	dB
Drain Efficiency	$\eta_{D}$	16.0	19.0	_	%
Pout @ 6 dB Compression Point	P6dB	35.0	37.0	_	dBm

Wideband Ruggedness <sup>(2)</sup> (In NXP Reference Circuit, 50 ohm system) I<sub>DQ</sub> = 12 mA, f = 3500 MHz, Additive White Gaussian Noise (AWGN) with 10 dB PAR

ISBW of 400 MHz at 55 Vdc, 0.58 W Avg. Modulated Output Power (3 dB Input Overdrive from 0.28 W Avg. Modulated Output Power)	No Device Degradation
(e az mpar e remaine mem elze m megaliarea e apar e elle)	

Typical Performance (2) (In NXP Reference Circuit, 50 ohm system) V<sub>DD</sub> = 48 Vdc, I<sub>DQ</sub> = 12 mA, 3400–3600 MHz Bandwidth

VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW <sub>res</sub>	_	300	_	MHz
Gain Flatness in 200 MHz Bandwidth @ P <sub>out</sub> = 24.5 dBm Avg.		_	0.74	_	dB
Fast CW, 27 ms Sweep				l .	l .
Pout @ 6 dB Compression Point	P6dB	_	4.6	_	W
AM/PM (Maximum value measured at the P6dB compression point across the 3400–3600 MHz bandwidth)	Φ	_	-16	_	٥
Gain Variation over Temperature (–40°C to +85°C)	ΔG	—	0.032	_	dB/°C
Output Power Variation over Temperature (–40°C to +85°C)	ΔP6dB	—	0.007	_	dB/°C

### **Table 7. Ordering Information**

Device	Tape and Reel Information	Package
A5G35S004NT6	T6 Suffix = 5,000 Units, 12 mm Tape Width, 13-inch Reel	DFN 4.5 × 4

<sup>1.</sup> Part internally input matched.

## **Correct Biasing Sequence for GaN Depletion Mode Transistors**

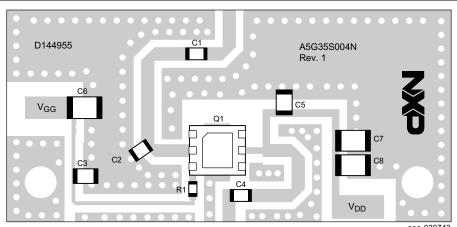
### **Turning the device ON**

- 1. Set  $V_{GS}$  to the pinch–off voltage, typically  $-5\ V.$
- 2. Turn on  $V_{DS}$  to nominal supply voltage (+48 V).
- 3. Increase  $V_{GS}$  until  $I_{DS}$  current is attained.
- 4. Apply RF input power to desired level.

#### Turning the device OFF

- 1. Turn RF power off.
- 2. Reduce  $V_{GS}$  down to the pinch-off voltage, typically  $-5\ V$ .
- 3. Adjust drain voltage  $V_{DS}$  to 0 V. Allow adequate time for drain voltage to reduce to 0 V from external drain capacitors.
- 4. Turn off  $V_{GS}$ .

<sup>2.</sup> All data measured in reference circuit with device soldered to printed circuit board.



Note: All data measured in reference circuit with device soldered to printed circuit board.

Figure 2. A5G35S004N Reference Circuit Component Layout

Table 8. A5G35S004N Reference Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C3, C4, C5	10 pF Chip Capacitor	600S100JT250XT	ATC
C2	1.6 pF Chip Capacitor	600S1R6BT250XT	ATC
C6, C7, C8	4.7 μF Chip Capacitor	GRM55ER72A475KA01B	Murata
Q1	RF Power GaN Transistor	A5G35S004N	NXP
R1	10 Ω, 1/10 W Chip Resistor	CRCW060310R0FKEA	Vishay
PCB	Rogers RO4350B , 0.020", $\epsilon_{\text{r}}$ = 3.66	D144955	MTL

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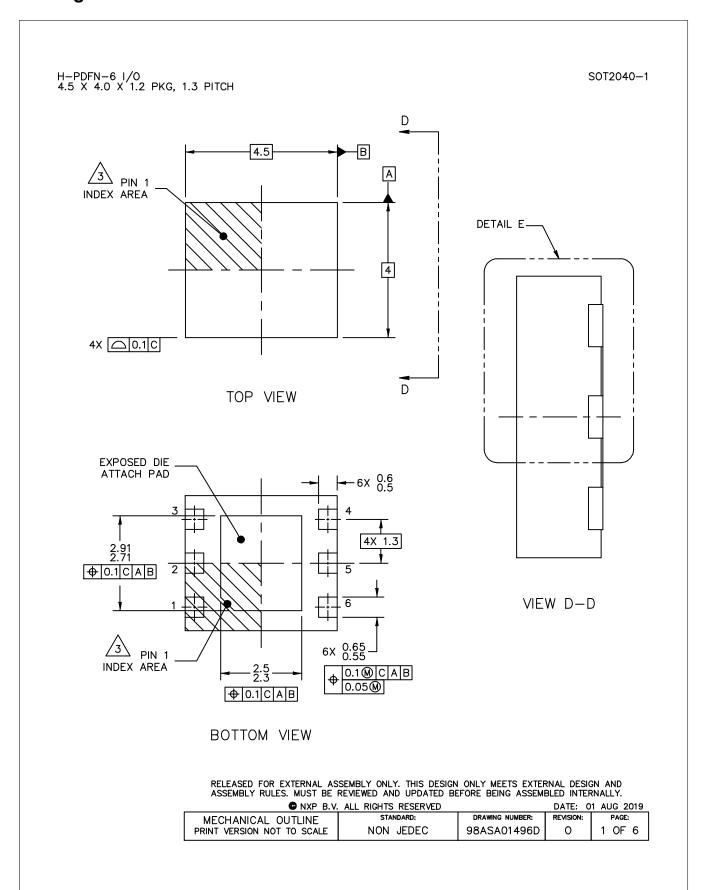
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Figure 3. Product Marking

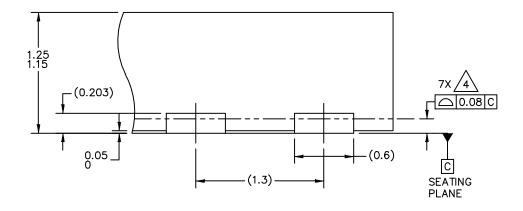
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## **Package Information**



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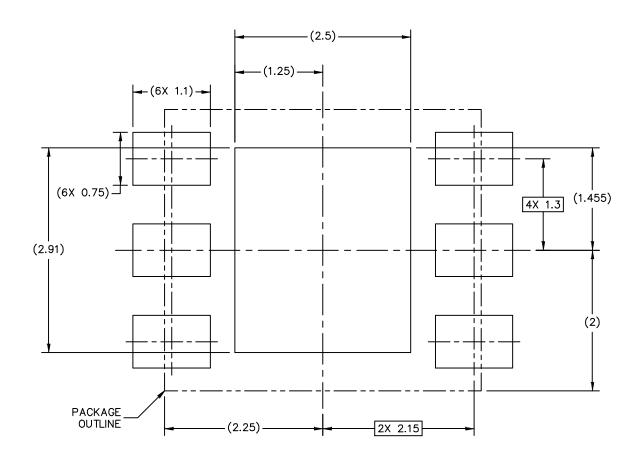
DETAIL E VIEW ROTATED 90°CW

RELEASED FOR EXTERNAL ASSEMBLY ONLY. THIS DESIGN ONLY MEETS EXTERNAL DESIGN AND ASSEMBLY RULES. MUST BE REVIEWED AND UPDATED BEFORE BEING ASSEMBLED INTERNALLY.

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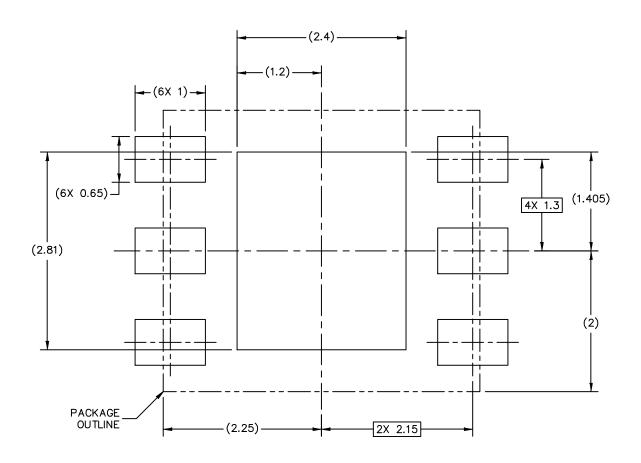
## PCB DESIGN GUIDELINES - SOLDER MASK OPENING PATTERN

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## PCB DESIGN GUIDELINES - I/O PADS AND SOLDERABLE AREA

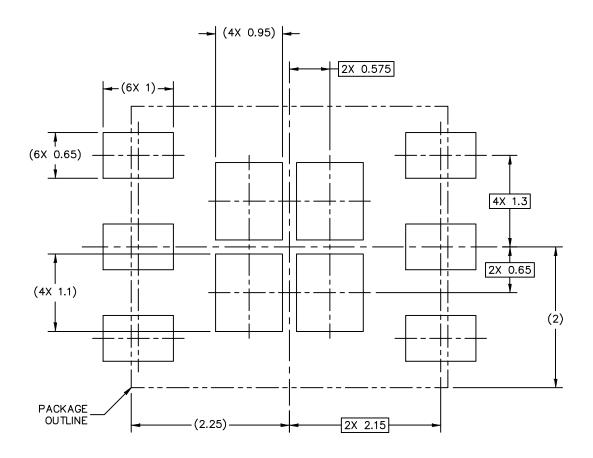
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RECOMMENDED STENCIL THICKNESS 0.125 OR 0.15

PCB DESIGN GUIDELINES - SOLDER PASTE STENCIL

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#### NOTES:

- 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

3.

3. PIN 1 FEATURE SHAPE, SIZE AND LOCATION MAY VARY.

COPLANARITY APPLIES TO LEADS AND DIE ATTACH FLAG.

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## **Product Documentation, Software and Tools**

Refer to the following resources to aid your design process.

### **Application Notes**

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

#### **Software**

.s2p File

### **Development Tools**

• Printed Circuit Boards

## **Revision History**

The following table summarizes revisions to this document.

Revision	Date	Description
0	Dec. 2020	Initial release of data sheet
1	Jan. 2021	<ul> <li>Table 1, Maximum Ratings: updated operating voltage for complete data sheet standardization, p. 2</li> <li>Table 2, Recommended Operating Conditions: added to data sheet, p. 2</li> </ul>
2	Jan. 2022	Table 6, DC On Characteristics, V <sub>GS(th):</sub> Min, Typ and Max values updated to match production test values, p. 2
3	July 2022	Table 6, DC On Characteristics, V <sub>GS(Q)</sub> : Min, Typ and Max values updated to match production test values, p. 2
4	Nov. 2022	<ul> <li>Table 1, Maximum Ratings: Gate–Source Voltage: updated –8, 0 to –16, 0 Vdc, p. 2</li> <li>Table 4, ESD Protection Characteristics, Human Body Model: updated to reflect test data, p. 2</li> <li>General updates made to align data sheet to current standard</li> </ul>

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